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	Substitute Form PTO-1449	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10449-022001	Application No. 09/696,393	
SEL	SEP 2 3 2005 by Applic		Applicant Tohru Watanabe		
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U.S. Patent Documents							
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	AA						
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111	AQ	Patent Abstracts of Japan, Publication No. 05-260385, Date of Publication October 8, 1993, Title: Defect Picture Element Detection Circuit for Solid-State Image Pickup Device			
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